COHERENT FIBER OPTIC TEMPERATURE SENSOR

A

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CERTIFICATE

This is to certify that "Amitesh Singh 814999 (10449979)" students of **Telecommunication Engineering** from "POLITECNICO DI MILANO, ITALY" has done their Thesis at "**Politecnico di Milano, Milano, ITALY**" in the partial fulfilment for the award of degree of "**Master of Science**" under the guidance of "**Prof. Mario Martinelli**" and "**Dott. Ing. Maddalena Ferrario**"

The project work entitled as **"COHERENT FIBER OPTIC TEMPERATURE SENSOR"** embodies the original work done for Thesis. This work has not been submitted partially or wholly to any other university or institute for the award of this or any other degree.

Prof. Maurizio Magarini The Department di Elettronica, Informazione e Bioingegneria. Dott. Ing. Maddalena Ferrario

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Amitesh Singh

DECLARATION BY SCHOLAR

I hereby declare that the work reported in my M.Sc. thesis entitled as "**Coherent Fiber Optic Temperature Sensor**," submitted at Department Di Elettronica, Informazione e Bioingegneria, Politecnico di Milano, is an authentic record of our research work carried out under the supervision of **Prof. Mario Martinelli** and **Dott. Ing. Maddalena Ferrario**. I have not submitted this work elsewhere for any other degree.

> Amitesh Singh (814999)

List of Abbreviations

S. No.	Abbreviation	Description
1.	FBG	Fiber-Bragg-Grating
2.	FRM	Faraday Rotation Mirrors
3.	DFB	Distributed Feedback Laser
4.	VCSEL	Vertical-Cavity Surface-Emitting Laser
5.	EMI	Electromagnetic Interference
6.	WDM	Wavelength-Division Multiplexing
7.	GMM	Giant Magnetostrictive Materials
8.	FRIS	Free Running Interferometric Sensor
9.	FM	Frequency modulation
10.	RTM	Real-Time Measurements
11.	HT	High Temperature
12.	EFPI	Extrinsic Fabry-Pérot interferometric
13.	DFPI	Diaphragm-based Fabry-Perot Interferometric
14.	FOS	Fiber Optic Sensor
15.	LB	Large Bandwidth
16.	HS	High Sensitivity
17.	CPS	Conventional Pressure Sensors
18.	HF	High Frequency
19.	HR	High Reliability
20.	IS	Intrinsic Sensors
21.	ES	Extrinsic Sensors
22.	TD	Time delay
23.	OTD	Optical Time-Domain
24.	OFD	Optical Frequency Domain
25.	LFG	Long-period Fiber Grating
26.	MRI	Magnetic Resonance Imaging
27.	DTS	Distributed Temperature Sensing
28.	RTD	Resistance Temperature Detectors
29.	II	Extrinsic Interferences
30.	EI	Intrinsic Interferences

31.	FODS	Fiber Optic Displacement Sensor
32.	POF	Plastic Optical Fiber
33.	SMF	Single-Mode Fiber
34.	MMF	Multi-Mode Fiber
35.	BFL	Brillouin Fiber Laser
36.	OTDR	Optical Time Domain Reflectometry
37.	OFDR	Optical Frequency Domain Reflectometry
38.	FFT	Fast Fourier Transform
39.	WSR	Wavelength-Specific Reflector
40.	AFC	Anti-Reflective Coating
41.	PMT	Photomultiplier Tubes
42.	IFS	Interferometric Fiber Sensor
43.	PMFS	Phase-Modulated Fiber Sensor
44.	FOIS	Fiber Optic Interferometric Sensors
45.	RI	Refractive Index
46.	OWN	Optical Wave Number
47.	OPD	Optical Phase Delay
48.	SA	Sensing arm
49.	RA	Reference arm
50.	DC	Direct Coupling
51.	IDC	Indirect Coupling
52.	QPS	Quadratic-Phase Signal
53.	TDF	Time-Domain Function
54.	FDF	Frequency-Domain Function
55.	LD	Laser Diode
56.	LED	Light-Emitting Diode
57.	FOC	Fiber Optic Communications
58.	ILD	Injection Laser Diode
59.	DBR	Distributed Bragg Reflector
60.	DQE	Differential Quantum Efficiency
61.	HRM	High Reflectivity Mirrors
62.	EEL	Edge-Emitting Lasers
63.	VCSOA	Vertical-Cavity Semiconductor Optical Amplifiers

64.	TDL	Tunable Diode Laser
65.	SMSR	Side Mode Suppression Ratio
66.	NPB	Narrow Pass Band
67.	LED	Light-Emitting Device
68.	TEC	Thermoelectric Cooler
69.	RTO	Real Time Oscilloscope
70.	FOCT	Fiber Optic Coherent Technology
71.	QP	Quadrature Point
72.	FRM	Faraday Rotation Mirrors
73.	OSW	Optical Source Wavelength
74.	LT	Local Temperature

List of Symbols

S. No	Symbols	Description
1	λ_{B}	Bragg wavelength
2	n.	Effective refractive index of the grating in the
2	Tie	fiber is core
3	Λ	Grating period
4	Δλ	Bandwidth
5	^δ η ₀	Variation in the refractive index
6	Lg	Grating length
7	$P_{B}(\lambda_{B})$	Peak reflection
8	Ν	Number of periodic variations
9	Ρ _{Β(} λ)	Reflected power
10	Φ	Optical phase delay
11	n	Refractive index of the fiber core
12	k	Optical wave number
13	L	Physical length of the fiber
14	Pd	Photodiode
15	С	Velocity of light
16	nΔL	Optical path difference
17	ڋ	Strain optic correction factor
18	μ	Poisson's ratio, and
19	pij	Elements of the strain optic tensor
20	f(t)	Instantaneous frequency
21	k	Rate of frequency increase or chirp rate
22	Φ'(t)	Angular frequency

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<u>ABSTRACT</u>

In many industrial application fields (oil & gas and high voltage transformers...) the use of conventional electrical temperature sensors (e.g. thermocouples) is forbidden because of harsh environmental conditions or risk of explosions due to sparks. In these fields fiber optic sensor represent a valid alternative as they can withstand severe conditions (high temperature, pressure) and offer a complete electromagnetic immunity.

Already available commercial fiber optic temperature sensors are mainly of two types: distributed sensors, that is, they can provide the entire profile of temperature along the entire fiber length (even km) with high spatial resolution (Raman, Brillouin sensor). And local sensors is that, in this case the fiber is used only to transport the optical light but the actual sensor is a material with peculiar thermal properties (fluorescence, absorption) which is place on top of the fiber end face.

These commercial systems are still expensive monitoring solutions and their cost can only be sustained mainly by industries such those of the Oil & Gas and High-Voltage Transformers.

On the other hand, the Manufacturing Industry (packaging, mechanical, automotive...) is now realizing the importance of implementing predictive maintenance strategies to prevent the occurrence of failure and downtimes in the manufacturing process. The implementation of an effective predictive maintenance requires the installation of monitoring system comprising a plurality of conventional sensors (even temperature sensors) which can provide manifold real-time information on the machine condition. The manufacturing industry is however struggling with the still high costs and complexity of installation of these monitoring solutions based on conventional electrical sensors.

In this frame fiber optic sensors can bring a real innovation, due to their minimal invasiveness, electromagnetic immunity and capability to sense manifold environmental parameter with the same transducer, that is, the optical fiber. As mentioned above commercially available fiber optic sensors are however too expensive.

In the present work, we have decided to re-consider a coherent approach, that is, interferometric, to fiber optic sensors, to achieve a cost-effective solution that can be proposed also to the Manufacturing Industry.

Interferometric technique were already proposed more than 40 years ago, offering very high sensitivity and accuracy, but their actual in-field applicability has been limited by technological issues related to the stabilization of the interferometric working point and polarization fading.

In the present work to overcome, the above-mentioned issues a completely passive phase diversity receiver combined with Faraday rotation mirrors, respectively for quadrature point and polarization stabilization, have been exploited to develop a lowcost interferometric fiber optic sensor capable to reliably detect temperature variations in an industrial environment.

The present work are divided as follows: in the first chapter, a brief review of the fiber optic sensor peculiar properties is given while in the second chapter a more detailed description is provided related to fiber optic temperature sensors. In the third chapter a theoretical description of the coherent approach to fiber optic sensing is given. In particular, in order to convert temperature measurement which is a quasi-static parameter, in a dynamic measurement, which guarantees a better accuracy, coherent detection is associated with a wavelength modulation, that is, a chirp of the optical laser source. In chapter four different typology of laser source with different chirp characteristics are taken into account and compared to evaluate the optical source that allows better performance in terms of sensitivity and accuracy in coherent detection. Finally, in chapter five, the coherent fiber optic temperature sensor experimental setup is described and preliminary results are provided.

ABSTRACT

In molti settori industriali diversi campi di applicazione (oil & gas e trasformatori di alta tensione...) l'uso di tradizionali elettriche dei sensori di temperatura (ad esempio termocoppie) è vietato a causa delle severe condizioni ambientali o il rischio di esplosioni dovute a scintille. In questi campi sensore a fibra ottica rappresentano una valida alternativa in quanto possono resistere a condizioni difficili (ad alta temperatura, pressione) e offrono una completa immunità elettromagnetica.

Già disponibile in commercio sensori di temperatura in fibra ottica sono principalmente di due tipi: sensori distribuiti, che essi possono fornire tutto il profilo di temperatura lungo tutta la lunghezza della fibra (anche km) con elevata risoluzione spaziale (Raman, Brillouin sensore). E sensori locali è che in questo caso la fibra viene utilizzato solo per il trasporto della luce ottica ma il sensore effettivo è un materiale con una peculiare proprietà termiche (fluorescenza, assorbimento) che è posto sulla cima di la faccia finale della fibra.

Questi sistemi commerciali sono ancora costose soluzioni per il monitoraggio e il loro costo può essere sostenuta solo principalmente dalle industrie quali quelli dell'Oil & Gas e trasformatori di alta tensione.

D'altro canto, l'industria manifatturiera (imballaggio, meccanica, automotive...) è ora a rendersi conto dell importanza di attuare la manutenzione predittiva delle strategie per prevenire il verificarsi del guasto e tempi morti nel processo di fabbricazione. La realizzazione di un efficace manutenzione predittiva richiede l'installazione del sistema di monitoraggio comprendente una pluralità di sensori convenzionali (anche sensori di temperatura) che può fornire il collettore informazioni in tempo reale sulle condizioni della macchina. L'industria manifatturiera è tuttavia lottando con gli ancora elevati costi e complessità di installazione di queste soluzioni per il monitoraggio basato su convenzionali sensori elettrici.

In questa cornice i sensori a fibra ottica può portare una vera innovazione, a causa della loro invasività minima, immunità elettromagnetica e capacità di collettore di rilevamento del parametro ambientale con lo stesso trasduttore, cioè la fibra ottica. Come accennato in precedenza disponibili in commercio sensori a fibra ottica sono però troppo costoso.

Nel presente lavoro abbiamo deciso di ri-considera un approccio coerente, che è, interferometrico per sensori a fibre ottiche, per ottenere una soluzione conveniente che può essere proposto anche per il settore manifatturiero.

Tecnica interferometrica sono stati già proposti più di quarant anni fa, offrendo molto alta sensibilità e precisione, ma la loro effettiva nel campo di applicabilità è stata

limitata da problemi tecnologici legati alla stabilizzazione del interferometrica del punto di lavoro e polarizzazione fading.

Nel presente lavoro di superare il sopra menzionato questioni completamente una fase passiva di ricevitore in diversità combinata con la rotazione di Faraday specchi, rispettivamente per punto in quadratura e la stabilizzazione di polarizzazione, sono stati sfruttati per sviluppare un basso costo interferometriche di sensore a fibra ottica in grado di rilevare in maniera affidabile le variazioni di temperatura in un ambiente industriale.

Il presente lavoro sono suddivisi come segue: nel primo capitolo un breve riepilogo del sensore a fibra ottica peculiari proprietà è dato mentre nel secondo capitolo una descrizione più dettagliata è fornite relative ai sensori di temperatura in fibra ottica. Nel terzo capitolo una descrizione teorica di un approccio coerente di rilevamento a fibre ottiche è dato. In particolare, al fine di convertire la misura di temperatura che è quasi un parametro statico in una misura dinamica, che garantisce una migliore precisione, rilevamento coerente è associato ad una lunghezza d'onda di modulazione, che è, un chirp dell'ottica laser sorgente. Nel capitolo 4 la diversa tipologia di sorgente laser con diverse caratteristiche di pigolio sono presi in considerazione e rispetto per valutare la sorgente ottica che consente di ottenere prestazioni migliori in termini di sensibilità e precisione nel rilevamento coerente. Infine nel capitolo cinque, la coerente in fibra ottica del sensore di temperatura setup sperimentale è descritto e i risultati preliminari sono previsti.

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1.1 Introduction

In many fiber optic sensors, the fiber simply carries the light to the remote optical sensor at the end of the fiber. The light is then somehow modified and returned, typically through the same fiber, to the source module, where it is analyzed. This type of sensor is usually referred to as an intensity-type fiber sensor, and as stated, the fiber plays no role in the sensing mechanism. With these sensors, light typically has to leave the optical fiber to interact with the optical sensor at the end of the fiber, in many instances leading to substantial optical loss. There is, however, another class of fiber sensor where the fiber plays a more intimate role with the sensing mechanism, and the light is not required to exit the fiber at the sensor to interact with the field to be detected. In this type of device, the optical phase of the light passing through the fiber is modulated by the field to be detected. This phase modulation is then detected interferometrically, by comparing the phase of the light in the signal fiber to that in a reference fiber. This type of sensor has a number of attractive features. As the light remains in the fiber, the device usually has a very low optical loss, and because the device uses the interference of light, it is very sensitive. Through a number of mechanisms, the optical phase of the light passing through a fiber may be made sensitive to many parameters. It is also possible to multiplex this type of sensor very efficiently. This type of sensor is referred to as a phase-modulated or interferometric fiber sensor.

Fiber optic interferometric sensors, as well as having the advantages generally attributed to fiber sensors, such as electrically passive (safety), lightweight, immunity to electromagnetic interference (EMI), and multiplexing, have the additional advantages of geometric versatility of the sensing element, wide dynamic range, and extremely high sensitivity, It is worthwhile to describe in greater detail the form of some of these advantages. For an acoustic sensor, where approximately 30m of fiber is required for the acoustic element, the fiber could be wrapped so as to form a small golf-ball-sized omnidirectional hydrophone, or the element could be configured as a highly directional element of 30m length—or any size between these two extremes. As will be shown, fiber interferometric sensors can detect strains up to 10⁻¹³ to 10⁻¹⁵; this is the origin of their high sensitivity and wide dynamic range.

Consequently, there has been an intense research effort over the last 10 years to develop sensors that capitalize on these advantages. However, it is some of these "advantages" that have tended to slow the progress of this very promising technology. For instance, the ability to make the fiber sensitive to many different parameters leads to the problem of sensor selectivity. Acoustic sensors become accelerometers, accelerometers become temperature sensors, and magnetometers become

seismometers, which for high-performance, state-of-the-art sensors is undesirable. Another major difficulty is that while the relationship between the optical phase shift and the parameter to be detected is linear over many orders of magnitude, the output of the interferometer, owing to the "raised-cosine fringes," requires processing, which can limit dynamic range, degrade performance, and elevate the noise floor of the system.

The very high performance of the sensors also dictates stringent requirements on the multiplexing of these sensors, so as to retain the system's integrity with regard to performance & the basic principle of operation of these sensors is described: two beam interferometry. Two of the basic methods of interferometer demodulation are described. First is the active homodyne approach, which although not applicable to most real-world systems has had widespread use in the laboratory and may be described as the "beginners" demodulator. Incidentally, in the laboratory environment, this approach has the lowest noise floor typically achievable with these sensors. Unlike the active scheme, the second demodulation approach has no electrical components in the interferometer and because of this and the fact that the approach does not form a feedback loop to the interferometer, this is termed a passive approach. This and other passive approaches have had widespread use outside the laboratory. Some of the basic noise sources are also described here, including a brief discussion of semiconductor diode laser noise properties, as this is one of the most commonly used sources in fiber optic interferometric sensors. The problem of polarization fading is then described, and various approaches to overcome this problem are discussed.

In Section 2.1, we describe various interferometer configurations: Mach–Zehnder, Michelson, reflectometric, and Fabry–Perot. Also, a number of implementations, such as gradiometers and push–pull designs, are discussed. Finally, some of the most important applications of this technology are described. The most important group are those involving ac measurements and include strain, acoustic, and acceleration. Owing to thermally induced phase shifts in the interferometer, direct dc measurements of parameters are difficult. Techniques that permit interferometers to measure dc parameters are also described.

Fused fiber couplers are key devices in optical communications and optical fiber sensor systems that either combine or split optical signals [1-5]. The continuous inline structure of these devices offers many attractive features, such as a low insertion loss, low back reflection, good mechanical reliability, and no interface problems with other fiber systems. A typical 2×2 fused fiber coupler is made by heating and pulling two single mode fibers. The two separate fibers are fused into a combined and tapered body. The fused fiber coupler can perform many important functions, including optical power dividing, wavelength selective coupling and polarization splitting [6,7]. The desired characteristics of the coupler can be controlled through proper control of the



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tapered length. The spectral selectivity is an important property to achieve high sensitivity, high precision and high reliable sensing technology because the spectral response is immune to any optical source instability or optical loss in the fiber [8]. This study examined the feasibility of a 2×2 fused fiber coupler as a fiber optic sensor based on its spectral transmission. The taped region was covered with a thermo-optic external medium. The key hypothesis was that the transmission and coupling characteristics of the coupler can interact with the external medium through evanescent wave coupling. The environmental temperature affects the refractive index of the external medium, which can cause a shift in spectral transmission. Theoretical analysis predicted the device structural condition needed to achieve high sensitivity and explained the behavior of the sensor device. The feasibility for practical applications is also discussed.



Fig. 1.1.1 2x2 Coupler Schematic

Magnetic field sensors have been employed for a variety of applications, including magnetic anomaly detection, magnetic compass, mineral prospecting, noncontact switching, current measurement, and so on [1]. Fiber-optic sensors have been implemented to detect magnetic fields by using Faraday effect [2,3], fiber Bragg grating (FBG) [4], and Fabry–Perot interferometer [5]. Fiber optic sensors based on phase-modulating interferometers possess a high sensitivity, and can be employed to detect extremely weak time-varying magnetic perturbations [6]. Interferometric fiber-optic magnetic field sensors have been successfully developed for past few decades [6]. Although a high resolution has been obtained, most of these sensors are investigated by using active phase technique, especially the phase tracking demodulation [7–10]. The phase tracking demodulation introduces a feedback electrical signal, in which the measuring range is very narrow. The phase generated carrier (PGC) demodulation is an alternative method, which exhibits a good linearity in a large dynamic range [11]. However, this method requires a carrier signal, and the

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carrier frequency determines the upper frequency limit of the measured magnetic field. Fiber-optic magnetic field sensors based on magnetostrictive materials were first proposed in 1980 [12]. The strain in magnetostrictive materials induced by external magnetic field is transferred to the fiber, which results in the phase shift between the beams in the interferometer. Metallic glasses have been used in magnetic field sensors instead of bare nickel to obtain a higher sensitivity [8]. Other kinds of materials are also implemented to detect magnetic field, such as ceramic materials [9], amorphous ferromagnetic alloys [10], rare-earth giant magnetostrictive materials (GMMs)[13], and so on. GMMs have attracted tremendous interests for a few years because of their giant magneto strain in response to magnetic fields. Fortunately, these unfavorable characteristics can be reduced by introducing a proper bias magnetic field and a compressive prestress [14,15]. In this paper, an all-fiber magnetic field sensor is proposed for detecting the weak alternating magnetic field. The sensor is constructed in a fiber-optic Mach-Zehnder interferometer, and one arm of the interferometer is wrapped on a magnetic transducer. A 3 × 3 coupler is used in the interferometer to demodulate interferometric signals for recovering dynamic phase shifts. Distinct from the active phase demodulation, this 3×3 coupler based demodulation operates without any electrical signal. Besides, the 3 × 3 coupler based passive demodulation is quite suitable for high frequency measurements. Experimental results show that the sensor exhibits excellent linearity, good reversibility, and high sensitivity.



Fig. 1.1.2 3x3 Optical Fiber Coupler

The use of a fiber-optic Mach-Zehnder interferometer to measure differences in temperature or pressure between two single-mode fiber arms is described. Temperature or pressure changes are observed as a motion of an optical interference fringe pattern. Values are calculated for the pressure and temperature dependence of the fringe motion. Pressure and temperature measurements are made with the interferometer, and the experimental values for sensitivity.

INTRODUCTION AND MOTIVATION

Today the fiber Bragg grating (FBG) is the component widely used for temperature sensing. It takes advantage of the broad fiber communication band by using WDM technology. However FBG sensing systems need very expensive wavelength demodulation equipment and the cost of FBGs is still a little high. In this paper a simple temperature sensor based on fiber coupler is demonstrated. A conventional bare fiber coupler is packaged into a silica V groove, and its optical power splitting ratio is less sensitive to the surrounding temperature [6]. To enhance the temperature sensitivity of the fiber coupler, it was coated with organic–inorganic solgel film around the coupling region. Because of the organic dopants among the network of silica material, solgel film has a higher thermo-optical coefficient. As the ambient temperature varies, the changed refractive index of the coating film of the coupler leads to variation of coupling coefficient. Thus, temperature can be determined by monitoring the power ratio of the coupler. Compared with FBGs [7], the fiber coupler has the advantages of low cost, easy sensing signal processing, and good sensitivity after it is coated. Couplers are much simpler, and their fabrication technology is more mature.

Describe two dynamic interferometric techniques based on the use of electrically tunable lasers for measuring optical path length and path length changes. In one case it has recently been shown1 that with the use of a rapidly tunable laser, dc drifts and low frequency phase noise can be eliminated from an interferometer by an active stabilization scheme. Several other authors [2-5] have proposed and demonstrated other feedback schemes to obtain a similar effect. However, in some applications it will not be feasible or even desirable to stabilize the interferometer. For example, if the laser is to drive several independent interferometers, the stabilization scheme cannot be used. In the first of the two schemes described in this paper we will show that using a Free Running Interferometric Sensor (FRIS), which incorporates a rapidly tunable laser, it is possible to extract information from the sensor independently of dc drifts and low frequency phase noise. The FRIS system utilizes a passive interferometer, which is desirable in remote sensing applications, and the system also allows for the same laser source to drive several sensors simultaneously.

The second interferometric measurement scheme is a true FM technique, where the information signal is carried in the frequency channel of the detected light signal; it is suited for noncontact real-time measurements of refractive index or length of transparent materials.

It is becoming widely recognized that various types of sensor can be advantageously made by using optical fibers either as the medium for data transmission, or as the sensor transducer, or both. Fiber optics for sensor systems may be useful in the presence of a high electromagnetic noise background or in environments where electrical signals cannot be used, such as explosive atmospheres. We previously reported on methods of using optical fibers as temperature sensors, in which the propagation characteristics of the fiber are dependent on temperature in such a way that the intensity of the light transmitted by the fiber is a measure of the temperature of the fiber[2-3].

1.2 Motivation

Temperature measurement is an essential technology in many industry applications. Some applications such as temperature fiber optic sensor involve harsh environments. Acquiring accurate temperature measurements in these harsh environments has always challenged the available measurement technology. The motivation of this research is to meet the recent increasing needs for optical fiber temperature sensors capable of operating accurately and reliably in these harsh environments.

Gas turbine engines employed in civilian and military aircraft consume large amounts of jet fuel daily, and the energy consumption attributed to this industry is increasing. Under increasing demand by engine users, manufacturers are extending operating envelopes of gas turbine engines to their limits to achieve higher thrust, better efficiency, lower emissions, improved reliability and longer engine life. The industry consensus is that these goals can be realized by strategic measurements at various locations in an engine for design optimization and real-time diagnosis during service[5]. However, the operating environment within the engine, characterized strong EMI and high temperature, pressure, and turbulence, shortens the lifetimes of currently available sensors.

Pressure and temperature measurement is thus of great importance as the first step toward turbulence monitoring and control. Once in place, the sensor relays information to a control system that can automatically adjust the engine for smoother operation, which will improve the engine operational performance and reliability.

The widely used semiconductor pressure sensors have several major drawbacks. These include a limited maximum operating temperature of 482°C, poor reliability at high temperatures, severe sensitivity to temperature changes, and susceptibility to electromagnetic interference. Compared with conventional electronic sensors, fiber optic sensors have many advantages including small size, lightweight, high sensitivity, large bandwidth, and high reliability, immunity to electromagnetic interference and anti-corrosion and absence of a spark source hazard for flammable environments. Fiber optic sensors can also survive at much higher temperatures than conventional pressure sensors [6].

The basic operating principle of an extrinsic Fabry-Pérot interferometric (EFPI) [7, 8] enables the development of sensors that can operate in the harsh conditions associated with turbine engines and other aerospace propulsion applications, where

the flow environment is dominated by high-frequency pressure caused by combustion instabilities, blade passing effects, and other unsteady aerodynamic phenomena. Both static and dynamic pressures exist in turbine engines, which must be measured by one sensor. Diaphragm-based Fabry-Perot Interferometric (DFPI) fiber optic pressure sensors are capable of measuring static and dynamic pressure simultaneously. However, the existing (DFPI) sensors can only work below 500°C because of the sensing materials or bonding methods utilized [9-13].

More detailed background information and distributed temperature sensing & local sensing technology review will be presented in chapter 2. The principle of the coherent temperature fiber optic sensor with block diagram & equation is described in Chapter 3. Chapter 4 presents the laser chirp modulation techniques with simulation. Experimental results with simulations are presented in Chapter 5.

2.1 FIBER OPTIC TEMPERATURE SENSORS

Fiber optic temperature sensors are designed for use in environments where high levels of electrical interference exist or where intrinsic safety is an issue. A fiber optic sensor is a sensor that uses optical fiber either as the sensing element ("intrinsic sensors"), or as a means of relaying signals from a remote sensor to the electronics that process the signals ("extrinsic sensors").

Fibers have many uses in remote sensing. Depending on the application, fiber may be used because of its small size, or because no electrical power is needed at the remote location, or because many sensors can be multiplexed along the length of a fiber by using light wavelength shift for each sensor, or by sensing the time delay as light passes along the fiber through each sensor. Time delay can be determined using a device such as an optical time-domain reflectometer and wavelength shift can be calculated using an instrument implementing optical frequency domain reflectometry.

Fiber optic sensors are also immune to electromagnetic interference, and do not conduct electricity so they can be used in places where there is high voltage electricity or flammable material such as jet fuel. Fiber optic sensors can be designed to withstand high temperatures as well.

2.1.1 Intrinsic Sensors

Optical fibers can be used as sensors to measure strain, temperature, pressure and other quantities by modifying a fiber so that the quantity to be measured modulates the intensity, phase, polarization and wavelength or transit time of light in the fiber. Sensors that vary the intensity of light are the simplest, since only a simple source and detector are required. A particularly useful feature of intrinsic fiber optic sensors is that they can, if required, provide distributed sensing over very large distances.

Temperature can be measured by using a fiber that has evanescent loss that varies with temperature, or by analyzing the Raman scattering of the optical fiber. Electrical voltage can be sensed by nonlinear optical effects in specially-doped fiber, which alter the polarization of light as a function of voltage or electric field. Angle measurement sensors can be based on the Sagnac effect.

Special fibers like long-period fiber grating (LPG) optical fibers can be used for direction recognition. Photonics Research Group of Aston University in UK has some publications on vectorial bend sensor applications.



Optical fibers are used as hydrophones for seismic and sonar applications. Hydrophone systems with more than one hundred sensors per fiber cable have been developed. Hydrophone sensor systems are used by the oil industry as well as a few countries' navies. Both bottom-mounted hydrophone arrays and towed streamer systems are in use. The German company Sennheiser developed a laser microphone for use with optical fibers.

A fiber optic microphone and fiber-optic based headphone are useful in areas with strong electrical or magnetic fields, such as communication amongst the team of people working on a patient inside a magnetic resonance imaging (MRI) machine during MRI-guided surgery.

Optical fiber sensors for temperature and pressure have been developed for down whole measurement in oil wells. The fiber optic sensor is well suited for this environment as it functions at temperatures too high for semiconductor sensors (distributed temperature sensing).

Fiber-optic sensors have been developed to measure co-located temperature and strain simultaneously with very high accuracy using fiber Bragg gratings. This is particularly useful when acquiring information from small or complex structures. Fiber Bragg grating sensors are also particularly well suited for remote monitoring, and they can be interrogated 250 km away from the monitoring station using an optical fiber cable. Brillouin scattering effects can also be used to detect strain and temperature over large distances (20–120 kilometres).

2.1.2 Extrinsic Sensors

Extrinsic fiber optic sensors use an optical fiber cable, normally a multimode one, to transmit modulated light from either a non-fiber optical sensor, or an electronic sensor connected to an optical transmitter. A major benefit of extrinsic sensors is their ability to reach places which are otherwise inaccessible. An example is the measurement of temperature inside aircraft jet engines by using a fiber to transmit radiation into a radiation pyrometer located outside the engine. Extrinsic sensors can also be used in the same way to measure the internal temperature of electrical transformers, where the extreme electromagnetic fields present make other measurement techniques impossible.

Extrinsic fiber optic sensors provide excellent protection of measurement signals against noise corruption. Unfortunately, many conventional sensors produce electrical output which must be converted into an optical signal for use with fiber. For example, in the case of a platinum resistance thermometer, the temperature changes are

translated into resistance changes. The PRT must therefore have an electrical power supply. The modulated voltage level at the output of the PRT can then be injected into the optical fiber via the usual type of transmitter. This complicates the measurement process and means that low-voltage power cables must be routed to the transducer.

Extrinsic sensors are used to measure vibration, rotation, displacement, velocity, acceleration, torque, and temperature.

The need for temperature measurement exists in many applications such as in automated consumer products, automated production plants and high performance processors. Recent works have mainly focused on temperature sensors that satisfy user requirements for specific applications, and the main considerations are performance, dimension and reliability.

In fact, traditional low-cost solutions, such as thermocouples and resistance temperature detectors (RTDs), do not always yield satisfactory performance, e.g., when the fluid temperature has to be measured in hostile environments, in the presence of electromagnetic, chemical, and mechanical disturbances. Since signals from the thermoelectric sensors are normally mixed with intrinsic noise and extrinsic interferences, they may contain intolerable errors if not properly filtered.

Therefore, this type of sensors is inept for gauging temperature in micro fluidic or nanosized devices, in extreme marine environments, and underground geological sites where long distance measurement with precision is required. For such applications, fiber optical sensors offer a better alternative since the optical signal does not suffer from interference by electromagnetic fields and can be transmitted over extremely long distances without any significant loss Furthermore; they are relatively small in size, and compatible with other optical fiber devices.

To date, various types of fiber optic temperature sensors have been reported in the literatures and they are mostly based on fiber interferometric and fiber Bragg grating (FBG). However, the first types of sensors are rather expensive to produce and complicated to implement on-site. Fiber Bragg gratings are very efficient at temperature sensing and are easy to implement; however, they always need additional techniques to discriminate the Bragg shifts by temperature and by strain/compression and they also require expensive phase-masks.

In this chapter, a temperature sensor is demonstrated based on four different techniques; intensity modulated fiber optic displacement sensor (FODS), lifetime measurements, microfiber loop resonator (MLR) and stimulated brillouin scattering. The first sensor is based on a rugged, low cost and very efficient FODS utilizing a plastic optical fiber (POF)-based coupler as a probe and a linear thermal expansion of aluminum.



The second temperature sensor, which is based on fluorescence decay time in Erbium-doped silica fiber, has the advantage of incorporating a time based encoding system, which is less sensitive to system losses such as those associated with optical cables and connectors.

The MLR is formed by coiling a microfiber, which was obtained by heating and stretching a piece of standard silica single-mode fiber (SMF). The MLR is embedded in a low refractive index material for use in temperature measurement. The MLR-based temperature sensor has a low loss splicing with a standard SMF. Lastly, a temperature sensor is demonstrated using an SBS effect, which requires measurement of frequency shift. In the proposed sensor, a Brillouin pump is injected into one end of a ring cavity resonator, in which a sensing fiber is located, and then the frequency shift between the BP and the Brillouin fiber laser (BFL) output is measured using a heterodyne method.

2.2 Distributed Temperature Sensor

Distributed temperature sensing systems (DTS) are optoelectronic devices, which measure temperatures by means of optical fibres functioning as linear sensors. Temperatures are recorded along the optical sensor cable, thus not at points, but as a continuous profile. A high accuracy of temperature determination is achieved over great distances.

Raman Effect - Principle physical measurement dimensions, such as temperature or pressure and tensile forces, can affect glass fibres and locally change the characteristics of light transmission in the fibre.

As a result of the damping of the light in the quartz glass fibres through scattering, the location of an external physical effect can be determined so that the optical fibre can be employed as a linear sensor. Optical fibres are made from doped quartz glass. Quartz glass is a form of silicon dioxide (SiO₂) with amorphous solid structure. Thermal effects induce lattice oscillations within the solid. When light falls onto these thermally excited molecular oscillations, an interaction occurs between the light particles (photons) and the electrons of the molecule. Light scattering, also known as Raman scattering, occurs in the optical fibre. Unlike incident light, this scattered light undergoes a spectral shift by an amount equivalent to the resonance frequency of the lattice oscillation. The light scattered back from the fibre optic therefore contains three different spectral shares:

• the Rayleigh scattering with the wavelength of the laser source used,

- the Stokes line components from photons shifted to longer wavelength (lower frequency), and
- The anti-Stokes line components with photons shifted to shorter wavelength (higher frequency) than the Rayleigh scattering.

The intensity of the so-called anti-Stokes band is temperature-dependent, while the so-called Stokes band is practically independent of temperature. The local temperature of the optical fibre is derived from the ratio of the anti-Stokes and Stokes light intensities.

OTDR and OFDR technology - There are two basic principles of measurement for distributed sensing technology, OTDR (Optical Time Domain Reflectometry) and OFDR (Optical Frequency Domain Reflectometry). For Distributed Temperature Sensing often a Code Correlation technology is employed which carries elements from both principles.



Fig.	2.2	Overview	of	DFB
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OTDR was developed more than 20 years ago and has become the industry standard for telecom loss measurements which detects the compared to Raman signal very dominant Rayleigh backscattering signals. The principle for OTDR is quite simple and is very similar to the time of flight measurement used for radar. Essentially a narrow laser pulse generated either by semiconductor or solid state lasers is sent into the fibre and the backscattered light is analysed. From the time it takes the backscattered light to return to the detection unit it is possible to locate the location of the temperature event.

Alternative DTS evaluation units deploy the method of Optical Frequency Domain Reflectometry (OFDR). The OFDR system provides information on the local characteristic only when the backscatter signal detected during the entire measurement time is measured as a function of frequency in a complex fashion, and

then subjected to Fourier transformation. The essential principles of OFDR technology are the quasi continuous wave mode employed by the laser and the narrow-band detection of the optical back scatter signal. This is offset by the technically difficult measurement of the Raman scatter light and rather complex signal processing, due to the FFT calculation with higher linearity requirements for the electronic components.

Code Correlation DTS sends on/off sequences of limited length into the fiber. The codes are chosen to have suitable properties, e.g. Binary Golay code. In contrast to OTDR technology, the optical energy is spread over a code rather than packed into a single pulse. Thus a light source with lower peak power compared to OTDR technology can be used, e.g. long life compact semiconductor lasers. The detected backscatter needs to be transformed similar to OFDR technology back into a spatial profile, e.g. by cross-correlation. In contrast to OFDR technology, the emission is finite (for example 128 bits) which avoids that weak scattered signals from far are superposed by strong scattered signals from short distance, improving the Shot noise and the signal-to-noise ratio. Using these techniques it is possible to analyse distances of greater than 30 km from one system and to measure temperature resolutions of less than 0.01°C.

2.3 Fiber Bragg grating

A fiber Bragg grating (FBG) is a type of distributed Bragg reflector constructed in a short segment of optical fiber that reflects particular wavelengths of light and transmits all others. This is achieved by creating a periodic variation in the refractive index of the fiber core, which generates a wavelength-specific dielectric mirror. A fiber Bragg grating can therefore be used as an inline optical filter to block certain wavelengths, or as a wavelength-specific reflector.

The fundamental principle behind the operation of a FBG is Fresnel reflection, where light travelling between media of different refractive indices may both reflect and refract at the interface.



Fig. 2.3.1 FBG Overview

The refractive index will typically alternate over a defined lengthFig. 5.2.c. The reflected wavelength (λ_B), called the Bragg wavelength, is defined by the relationship,

 $\lambda_{\text{B}}=2n_{e}\Lambda$

where n_e the effective refractive index of the grating in the fiber is core and Λ is the grating period. The effective refractive index quantifies the velocity of propagating light as compared to its velocity in vacuum. n_e Depend not only on the wavelength but also (for multimode waveguides) on the mode in which the light propagates. For this reason, it is also called modal index.





The wavelength spacing between the first minima (nulls, see Fig. 2), or the bandwidth $(\Delta \lambda)$, is (in the strong grating limit) given by,

 $\Delta \lambda = [2^{\delta} n_0 \eta / \pi] \ \lambda_{\rm B}$

Where δn_0 is the variation in the refractive index $(n_3 - n_2)$, and η is the fraction of power in the core. Note that this approximation does not apply to weak gratings where the grating length, L_g, is not large compared to $\lambda_B \setminus \delta n_0$.

The peak reflection $(P_{B(\lambda B)})$ is approximately given by,

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$$P_B(\lambda_B) \approx \tanh^2 \left[\frac{N\eta(V)\delta n_0}{n} \right]$$

where *N* is the number of periodic variations. The full equation for the reflected power $(P_B(\lambda))$, is given by,

$$P_B(\lambda) = \frac{\sinh^2 \left[\eta(V) \delta n_0 \sqrt{1 - \Gamma^2 \frac{N\Lambda}{\lambda}} \right]}{\cosh^2 \left[\eta(V) \delta n_0 \sqrt{1 - \Gamma^2 \frac{N\Lambda}{\lambda}} \right] - \Gamma^2}$$

where,

$$\Gamma(\lambda) = \frac{1}{\eta(V)\delta n_0} \left[\frac{\lambda}{\lambda_B} - 1 \right]$$



Fig. 2.3.3 FBG Spectral Response

2.4 Local Temperature Sensors

2.4.1 Fabry–Pérot Interferometer

In optics, a Fabry–Pérot interferometer or etalon is typically made of a transparent plate with two reflecting surfaces, or two parallel highly reflecting mirrors. (Technically the former is an etalon and the latter is an interferometer, but the terminology is often used inconsistently.) Its transmission spectrum as a function of wavelength exhibits peaks of large transmission corresponding to resonances of the etalon. It is named after Charles Fabry and Alfred Perot. "Etalon" is from the French etalon, meaning "measuring gauge" or "standard".

Etalons are widely used in telecommunications, lasers and spectroscopy to control and measure the wavelengths of light. Recent advances in fabrication technique allow the creation of very precise tuneable Fabry–Pérot interferometers.

The heart of the Fabry–Pérot interferometer is a pair of partially reflective glass optical flats spaced micrometers to centimetres apart, with the reflective surfaces facing each other. (Alternatively, a Fabry–Pérot uses a single plate with two parallel reflecting surfaces.) The flats in an interferometer are often made in a wedge shape to prevent the rear surfaces from producing interference fringes; the rear surfaces often also have an anti-reflective coating.

In a typical system, illumination is provided by a diffuse source set at the focal plane of a collimating lens. A focusing lens after the pair of flats would produce an inverted image of the source if the flats were not present; all light emitted from a point on the source is focused to a single point in the system's image plane. In the accompanying illustration, only one ray emitted from point A on the source is traced.



Fig. 2.4 FPI Fringes

As the ray passes through the paired flats, it is multiply reflected to produce multiple transmitted rays which are collected by the focusing lens and brought to point A' on the screen. The complete interference pattern takes the appearance of a set of concentric rings. The sharpness of the rings depends on the reflectivity of the flats. If the reflectivity is high, resulting in a high Q factor, monochromatic light produces a set of narrow bright rings against a dark background. A Fabry–Pérot interferometer with high Q is said to have high finesse.

2.4.2 Intensity Sensors

An intensity interferometer is the name given to devices that use the Hanbury-Brown and Twiss effect. In astronomy, the most common use of such an astronomical interferometer is to determine the apparent angular diameter of a radio source or star. If the distance to the object can then be determined by parallax or some other method,



the physical diameter of the star can then be inferred. An example of an optical intensity interferometer is the Narrabri Stellar Intensity Interferometer. In quantum optics, some devices which take advantage of correlation and anti-correlation effects in beams of photons might be said to be intensity interferometers, although the term is usually reserved for observatories.

Either an intensity interferometer is built from two light detectors, typically radio antenna or optical telescopes with photomultiplier tubes (PMTs), separated by some distance, and called the baseline. Both detectors are pointed at the same astronomical source, and intensity measurements are then transmitted to a central correlator facility. A major advantage of intensity interferometers is that only the measured intensity observed by each detector must be sent to the central correlator facility, rather than the amplitude and phase of the signal. The intensity interferometer measures interferometric visibilities like all other astronomical interferometers. These measurements can be used to calculate the diameter and limb darkening coefficients of stars, but with intensity interferometers aperture synthesis images cannot be produced as the visibility phase information is not preserved by an intensity interferometer.

The first fiber optic sensors were developed even before low-loss fibers became available in the 1970s. They used bundles or single fibers to measure the light reflected or transmitted by an object. This technology, which is elementary by today's standards, nevertheless provided the advantages of fiber optics to a limited number of applications. As new fibers became available, the performance of sensors improved. The availability of durable single-fiber cables allowed efficient optical systems and miniature sensors to be employed. In addition to simple reflective and transmissive systems, fringe tracking, micro bending, total reflection, and photo elastic techniques were explored. Progress toward practical fiber optic sensors was rapid.

Intensity sensors are inherently simple and require only a modest amount of interface electronics. Figure 2.4.2 shows how a single-fiber reflective sensor operates.

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FIBER OPTIC TEMPERATURE SENSOR



Single-fiber intensity sensor with a movable reflector that varies light loss.

Fig. 2.4.2 Single Fiber Intensity Sensor

In this example, light travels along the fiber from left to right, leaves the fiber end in a cone pattern, and strikes a movable reflector. If the reflector is close to the fiber end (Fig. 2.4.2 a), most of the light is reflected back into the fiber; as the reflector moves farther from the end of the fiber, as shown in Fig. 2.4.2 b and c, less light is coupled back into the fiber. The monotonic relationship between fiber–reflector distance and returned light can be used to determine distance. The obvious limitation of this sensor, a limitation that is common to most intensity sensors, is lack of a suitable reference signal. If the light source output level changes, or losses in the fiber vary with time, an erroneous distance measurement will result.





Differential intensity sensor using one input and two output fibers



This can be compensated to a degree by using more sources, or as shown in Fig. 2.4.2.2.2, more fibers. Here, displacement transverse to the fiber axis is measured by providing two receiving fibers that share the light from a displaced fiber. By suitably combining the photocurrents from receiver fibers, a moderately linear relationship between displacement and output can be observed. This output is less sensitive to source amplitude variations than the sensor shown in Fig. 2.4.2.2.1. Lagakos et al. provide a good review of intensity displacement sensors. A force causes polarization changes that modulate light amplitude. This sensor suffers both from the reference problems mentioned above and from any response nonlinearity and hysteresis associated with the elastooptic material.


FIBER OPTIC TEMPERATURE SENSOR



Elastooptic modulation of polarized light.

Fig. 2.4.2.2.2 Elastooptic Modulation

2.4.3 Interferometric Sensors

In many fiber optic sensors, the fiber simply carries the light to the remote optical sensor at the end of the fiber. The light is then somehow modified and returned, typically through the same fiber, to the source module, where it is analyzed. This type of sensor is usually referred to as an intensity-type fiber sensor, and as stated, the fiber plays no role in the sensing mechanism. With these sensors, light typically has to leave the optical fiber to interact with the optical sensor at the end of the fiber, in many instances leading to substantial optical loss. There is, however, another class of fiber sensor where the fiber plays a more intimate role with the sensing mechanism, and the light is not required to exit the fiber at the sensor to interact with the field to be detected. In this type of device, the optical phase of the light passing through the fiber is modulated by the field to be detected. This phase modulation is then detected interferometrically, by comparing the phase of the light in the signal fiber to that in a reference fiber. This type of sensor has a number of attractive features. As the light remains in the fiber, the device usually has a very low optical loss, and because the device uses the interference of light, it is very sensitive. Through a number of mechanisms, the optical phase of the light passing through a fiber may be made sensitive to many parameters. As will be seen in Chapter 3, it is also possible to multiplex this type of sensor very efficiently. This type of sensor is referred to as a phase-modulated or interferometric fiber sensor.



FIBER OPTIC TEMPERATURE SENSOR

Fiber optic interferometric sensors, as well as having the advantages generally attributed to fiber sensors, such as electrically passive (safety), lightweight, immunity to electromagnetic interference (EMI), and multiplexing have the additional advantages of geometric versatility of the sensing element, wide dynamic range, and extremely high sensitivity. It is worthwhile to describe in greater etail the form of some of these advantages. For an acoustic sensor, where approximately 30m of fiber is required for the acoustic element, the fiber could be wrapped so as to form a small golf-ball-sized omnidirectional hydrophone, or the element could be configured as a highly directional element of 30m length—or any size between these two extremes. As will be shown, fiber interferometric sensors can detect strains up to ~ 10^{-13} to 10^{-15} ; this is the origin of their high sensitivity and wide dynamic range.

Consequently, there has been an intense research effort over the last 10 years to develop sensors that capitalize on these advantages. However, it is some of these "Advantages" that have tended to slow the progress of this very promising technology.



Fig. 2.4.3 Overview of Interferometric

For instance, the ability to make the fiber sensitive to many different parameters leads to the problem of sensor selectivity. Acoustic sensors become accelerometers, accelerometers become temperature sensors, and magnetometers become seismometers, which for high-performance, state-of-the-art sensors is undesirable. Another major difficulty is that while the relationship between the optical phase shift and the parameter to be detected is linear over many orders of magnitude, the output of the interferometer, owing to the "raised-cosine fringes," requires processing, which can limit dynamic range, degrade performance, and elevate the noise floor of the system. The very high performance of the sensors also dictates stringent requirements on the multiplexing of these sensors, so as to retain the system's integrity with regard to performance.

3.1 Theory of optical interferometry

In this chapter, the basic principle of operation of these sensors is described: two beam interferometry. Two of the basic methods of interferometer demodulation are described. First is the active homodyne approach, which although not applicable to most real-world systems has had widespread use in the laboratory and may be described as the "beginners" demodulator. Incidentally, in the laboratory environment, this approach has the lowest noise floor typically achievable with these sensors.

Unlike the active scheme, the second demodulation approach has no electrical components in the interferometer and because of this and the fact that the approach does not form a feedback loop to the interferometer, this is termed a passive approach. This and other passive approaches have had widespread use outside the laboratory. Some of the basic noise sources are also described here, including a brief discussion of semiconductor diode laser noise properties, as this is one of the most commonly used sources in fiber optic interferometric sensors. The problem of polarization fading is then described, and various approaches to overcome this problem are discussed.

In this section, we describe various interferometer configurations: Mach–Zehnder, Michelson, reflectometric, and Fabry–Perot. Also, a number of implementations, such as gradiometers and push–pull designs, are discussed. Finally, some of the most important applications of this technology are described. The most important group are those involving ac measurements and include strain, acoustic, and acceleration. Owing to thermally induced phase shifts in the interferometer, direct dc measurements of parameters are difficult. Techniques that permit interferometers to measure dc parameters are also described.





Fig. 3.1.1 Interference block diagram

Two-beam interferometry allows the measurement of extremely small differential phase shifts in the optical fiber generated by the measurand. The optical phase delay (in radians) of light passing through a fiber is given by

Φ=nkL

(3.1)

where n is the refractive index of the fiber core, k is the optical wave number in vacuum ($2\pi/I$, I being the wavelength), and L is the physical length of the fiber. It should be noted that nL is referred to as the optical path length. It should also be noted that

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conventional optical fiber can support two orthogonal polarization modes, and that owing to such effects as bending, the fiber becomes birefringent. Consequently, the light emerging from the fiber is in general elliptically polarized. It can be seen that the value of f may depend on the polarization of output light selected (as although L₁=L₂=L, for different polarization modes, $n_1 \neq n_2$, due to fiber birefringence).

Small variations in the phase delay are found by differentiation of

$$d\phi/\phi = dL/L + dn/n + dk/k$$
(3.2)

The first two terms are related to physical changes in the fiber caused by the perturbation to be measured. Accordingly, they describe the transduction mechanism by which fibers can act as sensors. Generally, changes in pressure, temperature, and magnetic field result in different contributions to $d\phi$ via the dL and dn terms. Most low-frequency (below 50 kHz) sensing mechanisms rely on some form of material bonded to the fiber, either as a coating or by adhesives, to produce dominantly dL terms. However, due to the strain optic coefficient of the fiber, an accompanying dn (of smaller magnitude and opposite sign in terms of $d\phi$) occurs. Methods to maximize dL and thus $d\phi$ are discussed later.

The last term takes into account any wavelength (or frequency) variation associated with the laser source. This term is useful in considering noise terms such as laser frequency jitter, which results in phase noise and is also important when considering some of the demodulation approaches.



Fig. 3.1.2 Block Diagram for Interferometry





Fig. 3.1.3 3x3 Fiber Coupler

3.2 Optical phase dependence on temperature

Pd₁= I_1 *Cos(ϕ_1) Pd₂= I_2 *Sin(ϕ_2) $\Delta \phi$ =arc(Pd₁/ Pd₂)

Considering the optical phase delay (in radians) of light passing through a fiber in terms of the optical frequency v,

$$\Phi = (2\pi nLv)/c \tag{3.1}$$

where c is the velocity of light. By changing the emission frequency of the light by dv, the optical phase delay can be varied. Now as the interferometer contains both a reference and a sensing arm, the differential phase shift is proportional to the optical path difference $n\Delta L$ and is given by

$$\Delta \Phi = (2\pi n \Delta L v)/c \tag{3.2}$$

The majority of fiber interferometric sensors rely on two basic mechanisms to produce $d\Phi$: direct or indirect coupling of strains to the sensing fiber and thermal effects. First we consider the response of the fiber to some perturbation such that, from (3.1),

$$\Phi = (2\pi nLv)/c$$

$$\Delta \Phi = kd(nL) = k(ndL + Ldn) \qquad (3.3)$$

$$\Delta \Phi = kL(ndL/L + dn) \qquad (3.4)$$

where n dL corresponds to a physical change in length and L dn to changes in the refractive index. Dependent on the mechanism of the response either the n dL or the L dn term may dominate. dL/L is the fiber strain. It may be shown that the phase response of the fiber to axial strain is given by

$$d\Phi = k\xi ndL \tag{3.5}$$

where ξ is the strain optic correction factor and is given by $1-n^2[(1-\mu)p_{12}-\mu p_{11}]/2$, μ is the Poisson's ratio, and p_{ij} are the elements of the strain optic tensor (Pockel's coefficients) of the fiber. Typically, ξ has a value of ~0.78 in silica glass fibers. Thus, the length change in the fiber plays the major role in strain sensing.

If we now consider the response of the fiber to temperature, from Eq. (3.3),

$$d\Phi/dT = k(n(dL/dT) + L(dn/dT))$$
(3.6)

for a typical silica fiber dL/(LdT)= $5x10^{-7}$ K⁻¹ and dn/dT=1 $x10^{-5}$ K⁻¹ such that clearly the refractive index term dominates (d Φ ~100 rad/(m K)). If, however, we consider the case of a silica fiber with a 1mm diameter nylon jacket, dL/(LdT) for the composite structure is now ~6.5 $x10^{-5}$ K⁻¹ such that now the thermally induced length change dominates the optical phase shift.

As mentioned earlier, two-beam interferometric fiber sensors of the Michelson and Mach–Zehnder types exhibit extremely high sensitivity to temperature and arrange of other measurand fields that can be transformed into strain in an optical fiber (i.e., pressure, acceleration, displacement, etc.). Unfortunately, the output of an interferometric fiber sensor is intrinsically ambiguous due to the periodic nature of the raised-cosine transfer function. Therefore, when dc measurands are of interest, the absolute value of the measurand cannot be determined when the sensor is initialized. A number of approaches to overcoming this ambiguity problem have been proposed



and demonstrated: (1) two-wavelength interrogation (2) combined interferometric/polarimetric configurations, and (3) nonlinear phase transduction mechanisms.

Dual-wavelength interrogation of the sensor can be used to circumvent the ambiguity limitation of the interferometric sensing approach if the upper and lower bounds of the sensor range are well defined. The principle of the approach is as follows. Using a demodulation technique based on determination of the interferometric phase excursion at two wavelengths, the unambiguous range of a basic interferometric sensor can be increased substantially. The difference in the phase shift measured at each wavelength (λ_1 , λ_2) is a function of the interferometer path difference and displays unambiguous range ($\pm \pi$), which, depending on the actual wavelength difference used, can correspond to more than ± 100 individual interferometer fringes. Operation of the sensor within this range allows absolute determination of the measurand field (e.g., temperature) on initialization.

For an interferometer of path imbalance DL illuminated by two coherent sources of wavelength (frequency) $\lambda_1(v_1)$ and $\lambda_2(v_2)$, the phase differences between the arms of the interferometer at each wavelength are

$$\Delta \Phi_1(\lambda_1) = (2\pi n \Delta L)/\lambda_1 = (2\pi n \Delta L v_1)/c \qquad (3.7a)$$

$$\Delta \Phi_2(\lambda_2) = (2\pi n \Delta L)/\lambda_2 = (2\pi n \Delta L v_2)/c \qquad (3.7b)$$

where n is the core effective index (we assume DI is small so that dispersion can be neglected) and c is the free-space velocity of light. The relative phase difference is thus

$$\Delta \Phi = (2\pi n \Delta L(v_1 - v_2))/c \tag{3.8}$$



Interferometric output response with dual-wavelength operation.

Fig. 3.2 Output response for interferometric

The unambiguous range in ΔL is determined by $-\pi < \Delta \phi < \pi$. However, if DL consists of a finite path mismatch ΔL plus a measurand induced change dL, where $\Delta L'$ is much greater than the maximum dL, the determination of dL through the measurement of ΔL will depend critically on the stability of the laser frequencies. The wavelength instabilities become important only when the sensor output $\Delta \phi$ is approaching $-\pi$ radians.

4.1 LASER CHIRP MODULATION

A chirp is a signal in which the frequency increases or decreases with time. In some sources, the term chirp is used interchangeably with sweep signal. It is commonly used in sonar and radar, but has other applications, such as in spread spectrum communications. In spread spectrum usage, SAW devices such as RACs are often used to generate and demodulate the chirped signals. In optics, ultra short laser pulses also exhibit chirp, which, in optical transmission systems interacts with the dispersion properties of the materials, increasing or decreasing total pulse dispersion as the signal propagates.

4.1.1 Linear chirp

In a linear chirp, the instantaneous frequency f(t) varies linearly with time:

$$f(t) = f_0 + kt$$

where f_0 is the starting frequency (at time t = 0), and k is the rate of frequency increase or chirp rate.

$$k = \frac{f_1 - f_0}{T}$$

where f_1 is the final frequency and f_0 is the starting frequency. T is the time it takes to sweep from f_0 to f_1 .

The corresponding time-domain function for the phase of any oscillating signal is the integral of the frequency function, since one expects the phase to grow like $\phi(t + \Delta t) \simeq \phi(t) + 2\pi f(t) \Delta t$, i.e., that the derivative of the phase is the angular frequency $\phi'(t) = 2\pi f(t)$.

For the linear chirp, this results in:

$$\phi(t) = \phi_0 + 2\pi \int_0^t f(\tau) d\tau$$

= $\phi_0 + 2\pi \int_0^t (f_0 + k\tau) d\tau$
= $\phi_0 + 2\pi \left(f_0 t + \frac{k}{2} t^2 \right),$

where ϕ_0 is the initial phase (at time t = 0). Thus this is also called quadratic-phase signal.

The corresponding time-domain function for a sinusoidal linear chirp is the sine of the phase in radians:

$$x(t) = \sin\left[\phi_0 + 2\pi\left(f_0t + \frac{k}{2}t^2\right)\right]$$

In the frequency domain, the instantaneous frequency described by the equation $f(t) = f_0 + kt$ is accompanied by additional frequencies (harmonics) which exist as a fundamental consequence of frequency modulation. These harmonics are quantifiably described through the use of Bessel functions. However, with the aid of a frequency vs. time profile spectrogram one can readily see that the linear chirp has spectral components at harmonics of the fundamental chirp.

4.1.2 Exponential chirp

In a geometric chirp, also called an exponential chirp, the frequency of the signal varies with a geometric relationship over time. In other words, if two points in the waveform are chosen, t_1 and t_2 , and the time interval between them $t_2 - t_1$ is kept constant, the frequency ratio $f(t_2)/f(t_1)$ will also be constant.

In an exponential chirp, the frequency of the signal varies exponentially as a function of time:

$$f(t) = f_0 k^t$$

where f_0 is the starting frequency (at t = 0), and k is the rate of exponential increase in frequency. Unlike the linear chirp, which has a constant chirp rate, an exponential chirp has an exponentially increasing chirp rate.



The corresponding time-domain function for the phase of an exponential chirp is the integral of the frequency:

$$\phi(t) = \phi_0 + 2\pi \int_0^t f(\tau) \, d\tau$$

= $\phi_0 + 2\pi f_0 \int_0^t k^\tau d\tau$
= $\phi_0 + 2\pi f_0 \left(\frac{k^t - 1}{\ln(k)}\right)$

Where ϕ_0 is the initial phase (at t = 0).

The corresponding time-domain function for a sinusoidal exponential chirp is the sine of the phase in radians:

$$x(t) = \sin\left[\phi_0 + 2\pi f_0\left(\frac{k^t - 1}{\ln(k)}\right)\right]$$

As was the case for the Linear Chirp, the instantaneous frequency of the Exponential Chirp consists of the fundamental frequency $f(t) = f_0 k^t$ accompanied by additional harmonics.

4.2 LASER DIODES

A laser diode, or LD, is an electrically pumped semiconductor laser in which the active laser medium is formed by a p-n junction of a semiconductor diode similar to that found in a light-emitting diode.

The laser diode is the most common type of laser produced with a wide range of uses that include fiber optic communications, barcode readers, laser pointers, CD/DVD/Bluray Disc reading and recording, laser printing, laser scanning and increasingly directional lighting sources.

4.2.1 Operation

A laser diode is electrically a P-i-n diode. The active region of the laser diode is in the intrinsic (I) region and the carriers (electrons and holes) are pumped into that region from the N and P regions respectively. While initial diode laser research was conducted on simple P-N diodes, all modern lasers use the double-hetero structure implementation, where the carriers and the photons are confined in order to maximize their chances for recombination and light generation. Unlike a regular diode, the goal for a laser diode is to recombine all carriers in the I region, and produce light. Thus, laser diodes are fabricated using direct band-gap semiconductors. The laser diode epitaxial structure is grown using one of the crystal growth techniques, usually starting from an N doped substrate, and growing the I doped active layer, followed by the P doped cladding, and a contact layer. The active layer most often consists of quantum wells, which provide lower threshold current and higher efficiency.[1]

Laser diodes form a subset of the larger classification of semiconductor p-n junction diodes. Forward electrical bias across the laser diode causes the two species of charge carrier – holes and electrons – to be "injected" from opposite sides of the p-n junction into the depletion region. Holes are injected from the p-doped, and electrons from the n-doped, semiconductor. (A depletion region, devoid of any charge carriers, forms as a result of the difference in electrical potential between n- and p-type semiconductors wherever they are in physical contact.) Due to the use of charge injection in powering most diode lasers, this class of lasers is sometimes termed "injection lasers "or" injection laser diode" (ILD). As diode lasers are semiconductor devices, they may also be classified as semiconductor lasers. Either designation distinguishes diode lasers from solid-state lasers.

4.2.2 Different type of laser diode

The simple laser diode structure, described above, is extremely inefficient. Such devices require so much power that they can only achieve pulsed operation without damage. Although historically important and easy to explain, such devices are not practical.

4.2.2.1 VCSEL

The vertical-cavity surface-emitting laser, or VCSEL, is a type of semiconductor laser diode with laser beam emission perpendicular from the top surface, contrary to conventional edge-emitting semiconductor lasers (also in-plane lasers) which emit from surfaces formed by cleaving the individual chip out of a wafer.

There are several advantages to producing VCSELs, in contrast to the production process of edge-emitting lasers. Edge-emitters cannot be tested until the end of the production process. If the edge-emitter does not function properly, whether due to bad contacts or poor material growth quality, the production time and the processing materials have been wasted. VCSELs however, can be tested at several stages throughout the process to check for material quality and processing issues. For instance, if the vias have not been completely cleared of dielectric material during the etch, an interim testing process will flag that the top metal layer is not making contact to the initial metal layer. Additionally, because VCSELs emit the beam perpendicular to the active region of the laser as opposed to parallel as with an edge emitter, tens of thousands of VCSELs can be processed simultaneously on a three inch Gallium Arsenide wafer. Furthermore, even though the VCSEL production process is more labor and material intensive, the yield can be controlled to a more predictable outcome.

4.2.2.1.1 Structure

The laser resonator consists of two distributed Bragg reflector (DBR) mirrors parallel to the wafer surface with an active region consisting of one or more quantum wells for the laser light generation in between. The planar DBR-mirrors consist of layers with alternating high and low refractive indices. Each layer has a thickness of a quarter of the laser wavelength in the material, yielding intensity reflectivities above 99%. High reflectivity mirrors are required in VCSELs to balance the short axial length of the gain region.

In common VCSELs the upper and lower mirrors are doped as p-type and n-type materials, forming a diode junction. In more complex structures, the p-type and n-type regions may be embedded between the mirrors, requiring a more complex semiconductor process to make electrical contact to the active region, but eliminating electrical power loss in the DBR structure.

In laboratory investigation of VCSELs using new material systems, the active region may be pumped by an external light source with a shorter wavelength, usually another laser. This allows a VCSEL to be demonstrated without the additional problem of achieving good electrical performance; however such devices are not practical for most applications.

VCSELs for wavelengths from 650 nm to 1300 nm are typically based on gallium arsenide (GaAs) wafers with DBRs formed from GaAs and aluminium gallium arsenide (AlxGa (1-x) As). The GaAs–AlGaAs system is favored for constructing VCSELs because the lattice constant of the material does not very strongly as the composition is changed, permitting multiple "lattice-matched" epitaxial layers to be grown on a GaAs substrate. However, the refractive index of AlGaAs does vary relatively strongly as the Al fraction is increased, minimizing the number of layers required to form an efficient Bragg mirror compared to other candidate material systems. Furthermore, at high aluminium concentrations, an oxide can be formed from AlGaAs, and this oxide can be used to restrict the current in a VCSEL, enabling very low threshold currents.

Recently the two main methods of restricting the current in a VCSEL were characterized by two types of VCSELs: ion-implanted VCSELs and Oxide VCSELs.

In the early 1990s, telecommunications companies tended to favor ion-implanted VCSELs. Ions, (often hydrogen ions, H+), were implanted into the VCSEL structure everywhere except the aperture of the VCSEL, destroying the lattice structure around the aperture, thus inhibiting the current. In the mid to late 1990s, companies moved towards the technology of oxide VCSELs. The current is confined in an oxide VCSEL by oxidizing the material around the aperture of the VCSEL. A high content aluminium layer that is grown within the VCSEL structure is the layer that is oxidized. Oxide VCSELs also often employ the ion implant production step. As a result in the oxide VCSEL, the current path is confined by the ion implant and the oxide aperture.

The initial acceptance of oxide VCSELs was plagued with concern about the apertures "popping off" due to the strain and defects of the oxidation layer. However, after much testing, the reliability of the structure has proven to be robust. As stated in one study by Hewlett Packard on oxide VCSELs, "The stress results show that the activation energy and the wear-out lifetime of oxide VCSEL are similar to that of implant VCSEL emitting the same amount of output power."

A production concern also plagued the industry when moving the oxide VCSELs from research and development to production mode. The oxidation rate of the oxide layer was highly dependent on the aluminium content. Any slight variation in aluminium would change the oxidation rate sometimes resulting in apertures that were either too big or too small to meet the specification standards.

Longer wavelength devices, from 1300 nm to 2000 nm, have been demonstrated with at least the active region made of indium phosphate. VCSELs at even higher wavelengths are experimental and usually optically pumped. 1310 nm VCSELs are

desirable as the dispersion of silica-based optical fiber is minimal in this wavelength range.

4.2.2.1.2 Characteristic

- Multiple active region devices (aka bipolar cascade VCSELs). Allows for differential quantum efficiency values in excess of 100% through carrier recycling.
- VCSELs with tunnel junctions. Using a tunnel junction (n+p+), an electrically advantageous n-n+p+-p-i-n configuration can be built that also may beneficially influence other structural elements (e.g. in the form of a Buried Tunnel Junction (BTJ)).
- Widely tuneable VCSELs with micromechanically (MEMS) movable mirrors (either optically [1] or electrically pumped [2])
- Wafer-bonded or wafer-fused VCSEL: Combination of semiconductor materials that can be fabricated using different types of substrate wafers.
- Monolithically optically pumped VCSELs: Two VCSELs on top of each other. One of them optically pumps the other one.
- VCSEL with longitudinally integrated monitor diode: A photodiode is integrated under the back mirror of the VCSEL.
- VCSEL with transversally integrated monitor diode: With suitable etching of the VCSEL's wafer, a resonant photodiode can be manufactured that may measure the light intensity of a neighbouring VCSEL.
- VCSELs with external cavities, known as VECSELs or semiconductor disk lasers. VECSELs are optically pumped with conventional laser diodes. This arrangement allows a larger area of the device to be pumped and therefore more power can be extracted - as much as 30W. The external cavity also allows intracavity techniques such as frequency doubling, single frequency operation and femtosecond pulse mode locking.
- Vertical-cavity semiconductor optical amplifiers, known as VCSOAs. These devices are optimized as amplifiers as opposed to oscillators. VCSOAs must be operated below threshold and thus require reduced mirror reflectivities for decreased feedback. In order to maximize the signal gain, these devices contain a large number of quantum wells (optically pumped devices have been demonstrated with 21–28 wells) and as a result exhibit single-pass gain values which are significantly larger than that of a typical VCSEL (roughly 5%). These structures operate as narrow line width (tens of GHz) amplifiers and may be implemented as amplifying filters.

Because VCSELs emit from the top surface of the chip, they can be tested onwafer, before they are cleaved into individual devices. This reduces the fabrication cost of the devices. It also allows VCSELs to be built not only in one-dimensional, but also in two-dimensional arrays.

The larger output aperture of VCSELs, compared to most edge-emitting lasers, produces a lower divergence angle of the output beam, and makes possible high coupling efficiency with optical fibers.

The high reflectivity mirrors, compared to most edge-emitting lasers, reduce the threshold current of VCSELs, resulting in low power consumption. However, as yet, VCSELs have lower emission power compared to edge-emitting lasers. The low threshold current also permits high intrinsic modulation bandwidths in VCSELs.

The wavelength of VCSELs may be tuned, within the gain band of the active region, by adjusting the thickness of the reflector layers.

While early VCSELs emitted in multiple longitudinal modes or in filament modes, single-mode VCSELs are now common.

4.2.2.2 Distributed feedback laser

A distributed feedback laser (DFB) is a type of laser diode, quantum cascade laser or optical fiber laser where the active region of the device is periodically structured as a diffraction grating. The structure builds a one-dimensional interference grating (Bragg scattering) and the grating provides optical feedback for the laser.

DFB laser diodes do not use two discrete mirrors to form the optical cavity (as they are used in conventional laser designs). The grating acts as the wavelength selective element for at least one of the mirrors and provides the feedback, reflecting light back into the cavity to form the resonator. The grating is constructed so as to reflect only a narrow band of wavelengths, and thus produce a single longitudinal lasing mode. This is in contrast to a Fabry-Perot Laser, where the facets of the chip form the two mirrors and provide the feedback. In that case, the mirrors are broadband and either the laser functions at multiple longitudinal modes simultaneously or easily jump between longitudinal modes. Altering the temperature of the device causes the pitch of the grating to change due to the dependence of refractive index on temperature. This dependence is caused by a change in the semiconductor laser's band gap with temperature and thermal expansion. A change in the refractive index alters the wavelength selection of the grating structure and thus the wavelength of the laser output, producing a wavelength tunable laser or TDL (Tunable Diode Laser). The tuning range is usually of the order of 6 nm for a ~50 K (90 °F) change in temperature,

while the line width of a DFB laser is a few megahertz. Altering of the current powering the laser will also tune the device, as a current change causes a temperature change inside the device. Integrated DFB lasers are often used in optical communication applications, such as DWDM where a tunable laser signal is desired as well as in sensing where extreme narrow line width is required, or in gas sensing applications, where the signal of the absorbing gas is detected while wavelength tuning the DFB laser.

There are alternatives to traditional types of DFB lasers. Traditionally, DFBs are antireflection coated on one side of the cavity and coated for high reflectivity on the other side (AR/HR). In this case the grating forms the distributed mirror on the antireflection coated side, while the semiconductor facet on the high reflectivity side forms the other mirror. These lasers generally have higher output power since the light is taken from the AR side, and the HR side prevents power being lost from the back side. Unfortunately, during the manufacturing of the laser and the cleaving of the facets, it is virtually impossible to control at which point in the grating the laser cleaves to form the facet. So sometimes the laser HR facet forms at the crest of the grating, sometimes on the slope. Depending on the phase of the grating and the optical mode, the laser output spectrum can vary. Frequently, the phase of the highly reflective side occurs at a point where two longitudinal modes have the same cavity gain, and thus the laser operates at two modes simultaneously. Thus such AR/HR lasers have to be screened at manufacturing and parts that are multimode or have poor side mode suppression ratio (SMSR) have to be scrapped. Additionally, the phase of the cleave affects the wavelength, and thus controlling the output wavelength of a batch of lasers in manufacturing can be a challenge.

An alternative approach is a phase-shifted DFB laser. In this case both facets are antireflection coated and there is a phase shift in the cavity. This could be a single 1/4 wave shift at the center of the cavity, or multiple smaller shifts distributed in the cavity. Such devices have much better reproducibility in wavelength and theoretically all lasers in single mode.

In DFB fibre lasers the Bragg grating (which in this case forms also the cavity of the laser) has a phase-shift centered in the reflection band akin to a single very narrow transmission notch of a Fabry–Pérot interferometer. When configured properly, these lasers operate on a single longitudinal mode with coherence lengths in excess of tens of kilometres, essentially limited by the temporal noise induced by the self-heterodyne coherence detection technique used to measure the coherence. These DFB fibre lasers are often used in sensing applications where extreme narrow line width is required.

When we want to use lasers for long distance communication we find that standard FP lasers have significant problems:

1. As seen above FP lasers produce many wavelengths over a spectral width of between 5 and 8 nm. Even if we are using the 1310 "zero dispersion" band or "dispersion shifted" fibre in the 1550 nm band there will still be some chromatic dispersion of the signal caused by dispersion being slightly different at the different wavelengths.

2. The "mode hopping" behaviour of FP lasers gives rise to "Mode Partition Noise" as described in 2.4.3, "Mode Partition Noise".

3. In Wavelength Division Multiplexed (WDM) systems we want to carry many multiplexed optical signals on the same fibre. To do this it is important for each signal to have as narrow a spectral width as possible and to be as stable as possible. Regular FP lasers have too great a spectral width for use in this application.

Distributed Feedback (DFB) lasers are one answer to this problem. The idea is that you put a Bragg grating into the laser cavity of an index-guided FP laser. This is just a periodic variation in the RI of the gain region along its length.52 the presence of the grating causes small reflections to occur at each RI change (corrugation). When the period of the corrugations is a multiple of the wavelength of the incident light, constructive interference between reflections occurs and a proportion of the light is reflected. Other wavelengths destructively interfere and therefore cannot be reflected. The effect is strongest when the period of the Bragg grating is equal to the wavelength of light used (first order grating). However, the device will work when the grating period is any (small) integer multiple of the wavelength. Thus only one mode (the one that conforms to the wavelength of the grating) can lase.



Fig.4.2.2.2.1 DFB Active Region

Early devices using this principle had the grating within the active region and were found to have too much attenuation. As a result the grating was moved to a waveguide layer immediately adjacent to (below) the cavity. The evanescent field accompanying the light wave in the cavity extends into the adjacent layer and interacts with the grating to produce the desired effect.

In principle a DFB laser doesn't need end mirrors. The grating can be made strong enough to produce sufficient feedback (reflection) for lasing to take place. However, in a perfect DFB laser there are actually two lines produced (one at each side of the Bragg wavelength). We only want one line. A way of achieving this and improving the efficiency of the device is to place a high reflectance end mirror at one end of the cavity and either an AR coating or just a cleaved facet at the output end. In this case the grating doesn't need to be very strong - just sufficient to ensure that a single mode dominates. The added reflections (from the end mirrors) act to make the device asymmetric and suppress one of the two spectral lines. Unfortunately they also act to increase the line width.

A schematic view of a DFB laser is shown in Figure DFB1. DFB lasers are very effective and widely used but they have a problem with chirp. There are two main sources of chirp:

1. When the current is switched on the charge carrier (electron and hole) flux in the cavity changes very rapidly. This causes a change in the refractive index. A change in refractive index (of course) changes the resonant wavelength of the grating and the wavelength of the laser output changes (typically the wavelength gets longer) in well less than a single bit time.

2. During lasing the cavity heats up. This also happens very quickly (in a lot less than a bit time). This heating has two principal effects:

a. It causes the RI of the cavity to change.

b. It changes the electron energy gap in the material.

In an FP laser (as distinct from a DBR or DFB laser) this change in the energy gap dominates other effects and is the predominant cause of chirp. In the DFB laser the energy gap change is irrelevant. This is because the energy gap covers a range of energies and the DFB resonant wavelength is determined by the grating spacing and the cavity RI. So long as the range of energies in the gap extends to cover the resonant wavelength then the device will lase.

This means that a DFB laser will chirp far less than an FP laser. This is because chirp in DFB lasers is caused by the effect of the change in RI. This effect is much smaller than the effect caused by the change in the energy gap (which dominates in FP lasers but doesn't affect DFBs).





Fig. 4.2.2.2.2 DFB Region

Sometimes DFB lasers are constructed with a quarter-wave phase shift in the middle section of the grating as shown in Figure DFB2. This phase shift introduces a sharp transmission "fringe" into the grating reflection band. The fringe acts to narrow the line width of the laser significantly.



Fig. 4.2.2.2.3 DFB Response

Figure DFB3 shows the reflective characteristics of an un-shifted and a shifted Bragg grating structure. Ascending values on the y-axis represent increasing percentage of reflection. The x-axis represents wavelength. The axes have not been scaled because the numerical values depend on the period and strength of the grating itself. The phase shifted case (on the right of the figure) shows that a narrow pass band exists in the middle of the reflection band. This is caused by the quarter-wave phase shift. What happens is that the reflected waves from each end of the grating will be out of phase with each other and hence will destructively interfere.

DFB lasers have a number of significant advantages over FP types:

- 1. They can exhibit very narrow line widths (of the order of 50 kHz).
- 2. They have quite low chirp as discussed above.
- 3. They typically have a very low Relative Intensity Noise (RIN).

Nothing however is completely without problems:

1. DBR lasers are extremely sensitive to reflections.

Any reflection entering the cavity will disturb the laser's stable resonance. This causes a widening of the line width. To the extent that reflections returning from the outside vary (see 2.4.4, "Reflections and Return Loss Variation" on page 67) this can also be a significant source of noise. To minimise the effects of this problem DFB lasers are often packaged with an isolator integrated within the assembly. However, these don't always suppress all reflections and additional steps must be taken in system design to minimise the problem.

2. They are sensitive to temperature variations in two ways:

a. The stable (average) temperature of the device has a very strong influence on wavelength. Wavelength variation on a scale of many seconds or longer doesn't have much detrimental effect on a single channel long distance communication system but it is a critical issue in WDM systems.

The device requires temperature control for stable operation. This is usually provided by including a "Peltier Effect" cooler in the laser package.

b. During transmission (in even one bit time) the cavity heats up. If a long series of "1" bits are transmitted this can cause a significant wavelength shift on a time scale too short to be compensated by the Peltier cooler. This introduces a requirement that higher layer link protocols be "balanced" and spend (on average) as much time in the "0" state as in the "1" state.

3. Varying conditions produce significant fluctuations in laser output power. This is undesirable for many reasons. To counter this PIN diode is often included in the laser package near the "back facet". This diode picks up a small proportion of generated light from the transmittance of the back facet and provides input to a feedback loop for control of laser drive current.

4. They have a relatively high cost. As seen above, to get stable operation you almost always need temperature control, power control and optical isolation. All this adds to the cost.

4.2.2.3 Laser Diode Packaging

The laser diode itself is a semiconductor chip, electric wires and electrodes. However commercially available laser diode are in a metal casing. This is due to the semiconductor device being weak to heat. Oscillation efficiency of the laser diode is higher compared to other lasers, but there is still energy that is not turned in to light, which becomes heat. In order to protect the semiconductor device from its own heat by dispatching it, laser diodes are sold in metal packaging. Below shows, typical laser diode, packages. More information will be explained in the package description.



Fig. 4.2.2.3.1 14-Pin Butterfly Mount

LD and LED are a similar light-emitting device using semiconductors. However, since LD's output is higher than the LED's, it is impossible to use a lens made of epoxy resin for the LD (the LED does), so the appearance of the package is very different.

The most popular package of the laser diode is the TO-Can package in the Fig. 4.2.2.3.2.1. The TO-Can package has various diameters.



Fig. 4.2.2.3.2 To-can Laser

The To-can has three pins. Two are the cathode and the anode of the laser diode chip. The remaining one is a cathode for the output monitoring. The top of the silver cylinder is the output window; the laser light is emitted from here. At the golden base part, it is



possible to attach the radiating plate. The following is a video that shows how the laser is emitted from the laser diode of a TO-Can package.

Pin placement of a TO-Can package



Fig. 4.2.2.3.3 To-can pin alignment

There are various types pin placement points of a To-can package, as shown billow. You'll have to conform to the pin arrangement when you connect them.

Normal LDs of today used as an excitation light source are modulated and connected to an optical fiber, as shown in the Fig. Most commonly used LD for fiber lasers and optical amplifiers is 14-pin butterfly package.

A typical 14-pin butterfly package is a single emitter type, which consists of a LD chip, optical isolator, Thermoelectric Cooler: TEC [1], and Photo Diode: PD for Laser beam monitoring (Wavelength or output monitor), and is outputted by a optical fiber attached to the ferrule.



Fig. 4.2.2.3.4 Description of package



Fig. 4.2.2.3.5 Structural blue print of fiber

Fig. 4.2.2.3.4/5 the (4) appearance (with FBG) and (5) package content of a 14-pin butterfly package's fiber pigtail.

The LD is sub-mounted to a Peltier device (TEC) for temperature control purpose. The laser outputted from the LD is focused into the optical fiber (single-mode, multi-mode, polarization-maintaining, large-diameter fiber etc.) by a micro lens. If there is a monitor PD (here a PIN Diode: p-intrinsic-n Photo Diode [2]), output can be monitored. After precise alignment they are fixed by YAG laser welding. Table shows the fiber pigtail LD used as excitation LD for fiber lasers [6-9]. A single-mode fiber: SMF pigtail LD can be fused with a SMF optic fiber, and mainly used for exciting rare-earth-doped SMF. A multi-mode fiber: SMF pigtail LD can be fused with the excitation port of an excitation combiner, and used mainly for exciting double-clad fiber DCF.

5.1 Chirp impact on phase fringes measurement

5.1.1 Phase-Chirp Simulation

In Fig. 5.1.1.1 when v is fixed, fiber length is directly proportional to the fringes. That is why it will be linear.

In Fig. 5.1.1.2 when fiber length (L) is fixed, same reason.

In Fig. 5.1.1.3 when both v & L is fixed, then also it has linear but when you increase temperature, we observe some change in fringes.







Fig. 5.1.1.2 Simulation for fringes depends on wavelength





Fig. 5.1.1.3 Simulation for temperature depend fringes

Temperature dependence equation, same as equation (3.6)

 $d\phi = (2\pi/c) [(ndL/dT) + (Ldn/dT)] dvdT$

In Fig. 5.1.1.4 temperature case, when we increase dv, then observe some change in temperature as well as in fringes, they might increase.



Fig 5.1.1.4 Simulation for different temperature & fringes vary

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5.1.2 Chirp Measurement Setup



Fig. 5.1.2.1 Chirp setup

In Fig. 5.1.2.1 it shows how to observe the chirp. Starting laser modulator is provide the variable current how much required for the laser. Wave shaper passed that so it was distortion synthesis in which complex spectra are produced from simple tones by altering the shape of the waveforms. So we can see the graph in oscilloscope & for tracing I used wavelength observer.



Fig 5.1.2.2 Setup Configuration



5.1.3 VCSEL Laser Chirp

- I use VCSEL laser to calculate the chirp.
- I modulate the frequency & amplitude-using simulator.
- Then using laser diode controller to control the current & with the help of analyzer, we can see the difference in two waveform.



• Difference in chirp is 1.365nm.

Fig. 5.1.3 Vcsel result



5.1.4 DFB/TO-CAN Laser Chirp

- Now use DSB laser to calculate the chirp.
- I have to fix the current then after I have to measure the laser wavelength. Also using temperature controller.
- Balance the wave shaper using Matlab file.
- Then using waveform generator to give few MHz & with the help of oscilloscope we can see the difference of two waveform.



• Difference in chirp is 0.5 nm.





Fig. 5.1.4.2 To-can result



Fig. 5.1.4.3 Simulation result for DFB & To-can

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5.2 Coherent fiber optic temperature sensor

5.2.1 Experimental setup with 3x3 coupler



Fig. 5.2.1.1 Coupler setup

In Fig 5.2.1.1 it shows how to perform fiber that was related to temperature using 3x3 coupler. Starting from pc that was given amplitude using Lab-view software then function generator provide frequency to laser modulator as well as oscilloscope you can see how much frequency given to laser modulator. Laser modulator provide the variable current how much required for the laser. That was given by 1 of coupler end and others 2 goes to photodiodes. Other side 2 ends are using fiber with mirror (one is sensing arm & reference arm). In sensing arm I used 1 meter external fiber which is dip in water so I observe some changes in fringes when temperature is increases. Fringes will be increases but at the threshold level after fringes will be decreases if you increase the temperature.

SIMULATION AND EXPERIMENTAL RESULTS



Fig 5.2.1.2 Setup for 3x3 coupler

In Fig 5.2.1.2 you can see the set up diagram which includes the instruments that can performed 3x3 coupler. Moreover, I'll attach a fig. 5.2.1.3 which includes fiber with inside boiler and heater.



Fig 5.2.1.3 Fiber dip in water with heating

5.2.2 Temperature experimental characterisations

In Fig 5.2.2.1 it shows 3 different colors which contain 20, 40 & 60 degree temperature in real time oscilloscope. After every step, it will increase the fringes.



Fig. 5.2.2.1 Simulation for different temperature



Fig.5.2.2.2 Mean & Std with different temperature

These curves refers to experimental results obtained with the same coherent setup but with a different unbalanced length between the sensing and reference arm. It is shown that Fig. 5.2.2.2, obtained with a longer unbalanced, guarantees a higher sensitivity as, for the same temperature range variation, a higher number of fringes is obtained with respect to the case of Fig. 5.2.2.3. Measurements confirm a linear response of the coherent setup with respect to temperature variations with a good standard deviation of around \pm -10% with respect to the mean fringe number, thus proving the feasibility of the proposed fiber optic technique for local temperature measures.



Fig. 5.2.2.3 Simulation for different temperature vary $20 - 75^{\circ}$
In this work of thesis, a fiber optic sensor for local temperature measurement has been presented. Fiber optic temperature sensors are already available on the market, mainly based on FBG (Fiber-Bragg-Grating) or phosphors tips technology. However, these solutions are still too expensive and not affordable for many industrial applications. Fiber optic coherent technology represents instead a new and costeffective solution with multipurpose sensing capabilities. In the present work, this approach has been exploited and specialized for temperature measurements.

After a brief introduction on the advantages offered by fiber optic sensors with respect to electrical ones and on the different typologies of temperature fiber optic sensors that have already been developed, the focus has been put on the main peculiarities of this new coherent approach with respect to traditional interferometric setups. In particular, it has been shown that the present approach solves two. main issues that have till now prevented the actual in-field applicability of highly sensitive interferometric schemes., that is, the need of an active-feedback stabilization of the interferometric working point (quadrature point) and the occurrence of signal fading due to signal polarization fluctuations. The former issue is solved by means of a passive coherent receiver, which simultaneously provides the in-face and guadrature components of the interferometric signal, allowing to always recovering the correct phase signal information regardless of the interferometric working point. Polarization fading issue instead has been solved by exploiting Faraday Rotation Mirrors (FRM) at the end of the reference and sensing arms, which guarantees a complete compensation of all polarization changes of the optical signal due to environmental perturbations acting on the fiber. In particular, in the present work a 3x3 fiber optic coupler has been used as a passive coherent receiver which, together with FRM, constitutes standard components of optical communications, thus proving how the hardware core of this coherent approach to sensing is a true cost-effective solution.

Moreover, the measurement of a quasi-static parameter, like temperature, has required introducing a modulation inside the basic coherent scheme in order to obtain a dynamic measurement of temperature, which allows better performance in term of accuracy and sensitivity with respect to static measurements. Thus in the present work it has been analyzed, both theoretically and through simulations, how to apply and optimize the modulation of the optical source wavelength. This wavelength modulation in coherent detection scheme transducers in the generation of phase fringes whose number depends on the optical length of the sensing fiber arm.

If variation of the optical sensing length occurs, as for example due to an increase in the local temperature, the number of phase fringes varies and allows detecting and recovering the temperature variation information. In particular, the chirp of three different laser sources, a DFB laser, To-can laser and a VCSEL has been characterized in order to evaluate the optical source capable to guarantee the optimal compromise between high source coherence and large wavelength modulation. Indeed these two parameters determine the final accuracy of the proposed measurement technique. VCSEL ended up to be the optimal source and thus has been exploited in the experimental setup that has been arranged to carry out temperature measurements with the coherent fiber optic sensing approach. Preliminary results proved the feasibility of the proposed techniques in reconstructing temperature profiles with a temperature accuracy of few degrees in a range between 20- 70C°. Future works will follows to extend the measurement range and the sensor measurement accuracy by selecting special protective fiber coatings and by exploiting more optimized laser optical sources.

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